

Notice of References Cited	Application/Control No. 10/662,170	Applicant(s)/Patent Under Reexamination LI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,321,920	05-1967	WALTER; et. al.	60/247
*	C	US-3,263,418	08-1966	LANGE et. al.	60/247
*	D	US-2,708,341	05-1955	ZUCROW	60/39.821
*	E	US-2,758,441	08-1956	KÄLIL et. al.	60/39.826
*	F	US-5,615,548	04-1997	Winfree et al.	60/247
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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